



The 15th International Conference

Beam Injection Assessment of Microstructures in Semiconductors

Saint-Petersburg, Russia, 19-24 July, 2020

Dear Colleagues,

On behalf of **BIAMS2020** Organizing Committee, we encourage you to participate in the 15th International Conference "Beam Injection Assessment of Microstructures in Semiconductors", which will be held on the 19-24 July, 2020 in Saint Petersburg, Russia.

We inform you that the abstract submission is already opened. The detailed information is available in the personal account on the website of the Conference, www.BIAMS2020.org. The registration is required.

We also have the pleasure to [announce](#) the Organizing Fee.

BIAMS2020 Conference acts as a forum for interaction between physicists, materials scientists and technologists; it gathers scientists from all over the world to present advances in the field of the physical characterization of semiconductors by means of beam injection and related methods. To learn more about the details please visit our website, where the data will be continuously updated. We encourage you to [register](#) for this event at your earliest convenience.

Looking forward to seeing you in Saint Petersburg.

*Professor Maria Zamoryanskaya, Chairman
and
The Local Organizing Committee.*

Contact:

email: info@BIAMS2020.org

tel: +7(931)-346-77-43

